Phase sensitive modulated multiplex scanning pattern Title:

imaging - using measuring duration per image element which

is shorter than cycle duration of modulation, and multiscanning each of several image elements during cycle

Patent Number:

DE4203272

Publication date:

1993-08-12

Inventor(s):

Applicant(s):

BUSSE GERD PROF DR RER NAT (DE)

Application Number: DE924203272 19920205

Priority Number(s):

DE924203272 19920205

IPC Classification:

G01M11/08; G01M13/00; G01N21/63; G01N25/72; G03B42/00;

G06F15/66

Requested Patent:

© DE4203272

Equivalents:

Abstract

The scanning alternatively can be carrier out during corresp. segments of successive cycles. For the computing of phase angle and amplitude of the local modulation effect, three of four equidistantly timed evaluations per cycle are used, for simplifying the evaluation per image element.

The unit scanning the object being tested is a thermography camera performing phase sensitive modulation thermography, heat wave thermography and lock in thermography. The temp. of the object under test is modulated without contact by the absorption of electromagnetic radiation. USE/ADVANTAGE - Thermography, electro-microscopy and tomography. Quick scanning pattern image method combined with low frequency effect modulation, to produce parameter cleaned phase images.